

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Applicant(s): Vincent Detalle et al

Serial No: Not Available

Filing Date: Herewith

Title: METHOD AND APPARATUS FOR THREE-
DIMENSIONAL COMPOSITIONAL MAPPING OF
HETEROGENEOUS MATERIALS

Docket No: 11330-1

14 November, 2001

To: The Commissioner of Patents
and Trademarks
Washington, D.C. 20231
U.S.A.

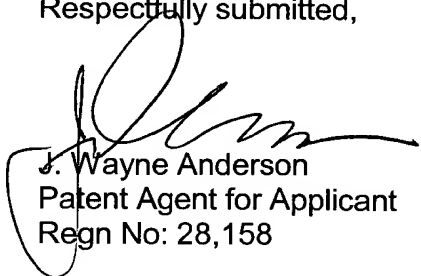
INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. 1.56

Sir:

Prior to examination by the Examiner, the Applicant respectfully submits prior art which has been considered for preparation of the present application.

References of the prior art are listed in PTO 1448 submitted herewith. Copies of the references are also attached herewith for Examiner's convenience.

Respectfully submitted,


J. Wayne Anderson
Patent Agent for Applicant
Regn No: 28,158

:ech

National Research Council Canada
Intellectual Property Services Office
M-58, EG-12, Montreal Road
Ottawa, Ontario K1A 0R6 Tel: 613-993-3899

#21IDS
1/10/02
C. McHenry



Form PTO 1449 U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	ATTY. DOCKET NUMBER: 11330-1	SERIAL NUMBER:
	APPLICANT: VINCENT DETALLE ET AL	
	FILING DATE: HERewith	GROUP:

11/16/01
 09/987819
 1c971 U.S. PTO

U.S. Patent Documents

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCL ASS	FILING DATE IF APPROPRIATE
	AA	5,781,289	July 14, 1998	Sabsabi and Bussière			
	AB	6,259,530	July 10, 2001	Monsallut			
	AC	4,627,731	December 9, 1986	Waters and Fernald			

Foreign Patent Documents

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							Yes	No
	AL							
	AM							

Other Documents (Including Author, Title, Date Pertinent Pages, Etc.)

	AR	Günther et al., Spectrochim. Acta Part B, vol. 54, 1999, p. 381
	AS	Kanický et al., Fresenius J. Anal. Chem., vol. 366, 2000, p. 228)
	AT	Wong et al., SPIE, vol. 2390, 1995, p. 68
	AU	Kay et al., Int. J. Impact Engng., vol. 19, 1997, p. 739
	AV	Borisov et al., Spectrochim. Acta Part B, vol. 55, 2000, p. 1693
	AW	Lausten and Balling, Appl. Phys. Lett., vol. 79, 2001, p. 884
	AX	Uebbing et al., Spectrochim. Acta Part B, vol. 47, 1992, p. 611
	AY	Rao and Jackson, Meas. Sci. Technol., vol. 7, 1996, p. 981
EXAMINER		DATE CONSIDERED
EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant		